

Search Notes

Application/Control No.

10/002,318

Examiner

Krista M. Flanagan

Applicant(s)/Patent under
Reexamination

MAGEE, DAVID PATRICK

Art Unit

2631

SEARCHED

Class	Subclass	Date	Examiner

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner
375	340	9/28/2005	KMF
375	345	9/28/2005	KMF

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST (Bocure)	1/24/2005	KMF
Inventorship EAST (Bocure)	1/28/2005	KMF
375/224, 226, 344, 345, 371, and 375 See Search Notes	1/24/2005	KMF
Updated Search - See Search Notes	7/18/2005	kmf
IEEE Xplore - See search notes	7/18/2005	KMF
Updated Search - See Search Notes	7/27/2005	KMF
Updated Search - See Search Notes	7/29/2005	KMF
375/345 375/371 375/226 375/444 375/375.ccls. see search notes for text.	9/28/2005	KMF